IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re application of: Plofsky

Attorney Docket No.: ALTRP082

Application No.: Filed Herewith Examiner: Unassigned

Filed: Filed Herewith Group: Unassigned

Title: EMBEDDED MICROPROCESSOR FOR INTEGRATED CIRCUIT TESTING AND

DEBUGGING

CERTIFICATE OF EXPRESS MAILING

I hereby certify that this paper and the documents and/or fees referred to as attached therein are being deposited with the United States Postal Service on July 29, 2003 in an envelope as "Express Mail Post Office to Addressee" service under 37 CFR §1.10, Mailing Label Number EV 33398 5031 US, addressed to the Commissioner for Patents, P.O. Box 1450 Alexandria, VA 22313-1450.

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INFORMATION DISCLOSURE STATEMENT 37 CFR §§1.56 AND 1.97(b)

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Dear Sir:

The U.S. patent(s) and U.S. published patent application(s) references listed in the attached PTO Form 1449, copies not required to be enclosed under 37 CFR 1.98 (a)(2)(1), and any and all other references listed in the attached PTO Form 1449, copies of which are attached, may be material to examination of the above-identified patent application. Applicants submit these references in compliance with their duty of disclosure pursuant to 37 CFR §§1.56 and 1.97. The Examiner is requested to make these references of official record in this application.

This Information Disclosure Statement is not to be construed as a representation that a search has been made, that additional information material to the examination of this application does not exist, or that these references indeed constitute prior art.

This Information Disclosure Statement is: (i) filed within three (3) months of the filing date of the above-referenced application, (ii) believed to be filed before the mailing date of a first Office Action on the merits, or (iii) believed to be filed before the mailing of a first Office

Action after the filing of a Request for Continued Examination under §1.114. Accordingly, it is believed that no fees are due in connection with the filing of this Information Disclosure Statement. However, if it is determined that any fees are due, the Commissioner is hereby authorized to charge such fees to Deposit Account 500388 (Order No. ALTRP082).

Respectfully submitted,

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Form 1449 (Modified)	Atty Docket No.	Application No.:
Information Disclosure	ALTRP082 Applicant:	Filed Herewith
Statement By Applicant	Plofsky	
	Filing Date	Group
(Use Several Sheets if Necessary)	Filed Herewith	Unassigned

U.S. Patent Documents

Examine				S. Patent Docum		Sub-	Filing
Initial	No.	Patent No.	Date	Patentee	Class	class	Date
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	2	4,788,492	11/29/88	Schubert			
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	4	4,847,612	07/11/89	Kaplinsky			
	5	4,873,459	10/10/89	El Gamo et al.			
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Examine						Sub-	Filing
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Foreign Patent or Published Foreign Patent Application

Examiner		Document	Publication	Country or		Sub-	Trans	lation
Initial	No.	No.	Date	Patent Office	Class	class	Yes	No
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Other Documents

		Other Documents
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	1	Marantz, Joshua, "Enhanced Visibility and Performance in Functional Verification by Reconstruction", Proceedings of the 35 th Annual Conference on Design Automation Conference, Pgs. 164-169. 1998.
	2	Stroud, Charles et al., "Evaluation of FPGA Resources for Built-in Self-test of Programmable Logic Blocks", Proceedings of the 1996 ACM 4 th International Symposium on Field-programmable Gate Arrays, Pg. 107. 1996.
	3	Collins, Robert R., "Overview of Pentium Probe Mode", (www.x86.org/ariticles/problemd/ProbeMode.htm), August 21, 1998, 3 pgs. \(\square\$
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	5	"PentiumPro Family Developer's Manual", Volum 1: Specifications, Intel®Corporation, 1996, 9 Pgs.
	6	"Pentium® Processor User's Manual", Volume 1, Intel®Corporation, 1993, Pgs. 3-11.
	7	Xilinx, Inc.; ISE Logic Design Tools: ChipScope J

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	8	Synplicity, Inc. "Identify TM RTL Debugger" 2003; Pg 1-2.		
	9	Altera, "SignalTap Analysis in the Quartus II Software Version 2.0; September 2002, ver. 2.1; Altera Corporation.		
Examiner		Date Considered		

Examiner: Initial citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.